

HI-WAVE

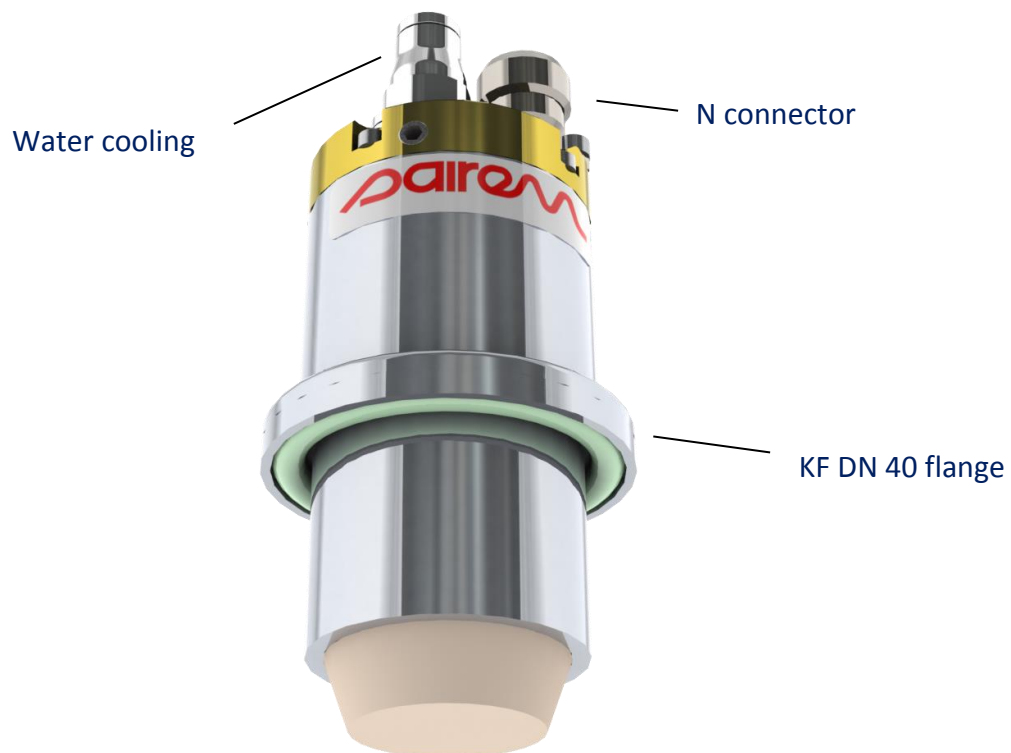
Ref. CPSKFDN40HP2D



The **HI-WAVE** microwave collisional plasma source has been designed to sustain microwave plasma from 10^{-2} mbar to a few 10^{-1} mbar and from a few watt microwave power whatever the gas. As the AURA-WAVE ECR coaxial plasma source, the **HI-WAVE** collisional coaxial plasma source was designed to avoid inside power-losses and has proved to be matched [1-4], i.e. no reflected power with no additional impedance matching system over 1 pressure decade, depending on the plasma gas. Moreover, plasma density higher than 10^{12} cm^{-3} could be easily obtained in multisource configuration at a few cm from the sources.

When combined with Sairem solid state microwave generator, it possible to control the power transmitted to the plasma with one watt increment; low mismatching that may appear in the operating conditions can be balanced due to the variable frequency of the solid state generator and thus permits to extend the operating condition range of the **HI-WAVE**.

HI-WAVE is designed to be used equally in R&D laboratories and industry for a very large range of applications. Typical applications of such source are generation of radicals (e.g. atomic oxygen), etching, PECVD (e.g. **nanocrystalline diamond deposition**), surface treatment (nitration, cleaning etc.), sterilization...



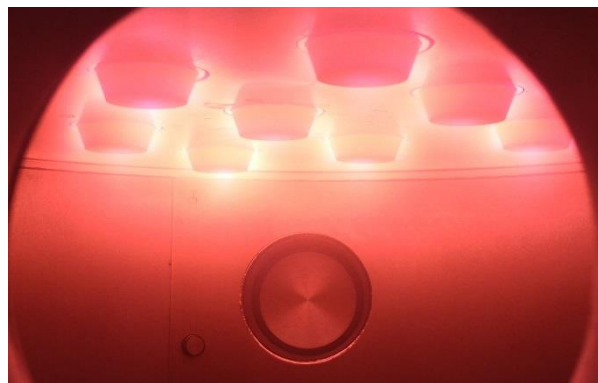
HI-WAVE collisional plasma source

Technical specification

REF	CPSKFDN40ECR2DP
Frequency	2400 – 2500 MHz, 0.1 MHz increment
Microwave power	Max. 200 W
Working pressure range	10 ⁻² mbar to a few 10 ⁻¹ mbar
Plasma density (measured in Ar-O ₂ -N ₂)	<u>One source:</u> 5 × 10 ¹⁰ cm ⁻³ to 2 × 10 ¹¹ cm ⁻³ at 160 mm 10 ¹¹ cm ⁻³ to 5 × 10 ¹¹ cm ⁻³ at 100 mm <u>Multisources:</u> 10 ¹¹ cm ⁻³ to 5 × 10 ¹¹ cm ⁻³ at 160 mm a few 10 ¹¹ cm ⁻³ to 10 ¹² cm ⁻³ at 100 mm
Connections	Standard KF DN40 flange
Cooling by water	Push-fit connectors for OD 6 mm tubing 0.5 l/min

OBSERVATIONS

Multi-sources can be used for scaling-up in crown distribution for volume plasma processing or in matrix distribution for planar plasma processing. As each **HI-WAVE** has its own microwave generator, it is possible to control exactly the transmitted power to each plasma source whatever the number. For example, in matrix distribution, the losses in uniformity due to edge effect of the peripheral plasma sources can be compensated by increasing their microwave power and thus increase the surface of uniform treatment area.



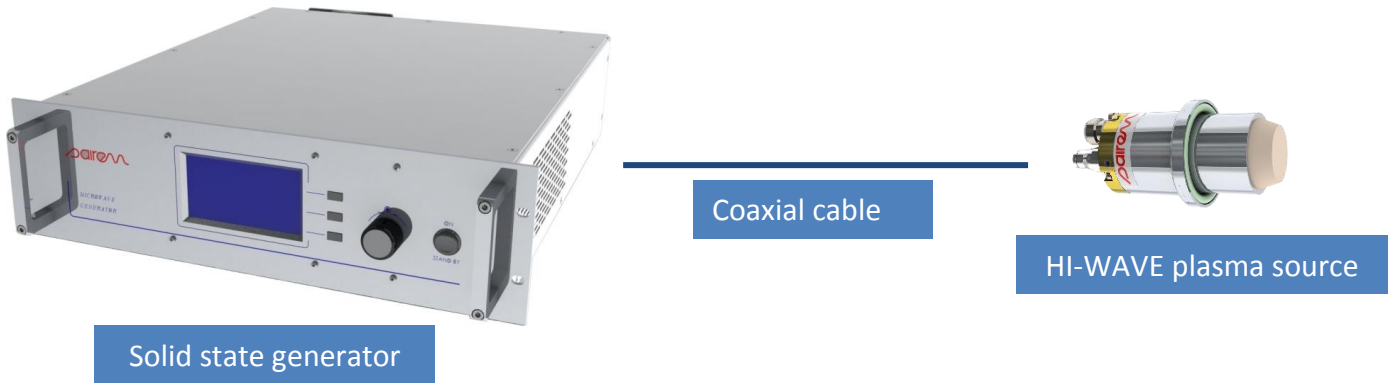
Example of integration of 8 **HI-WAVE** sources on the top lid of a plasma reactor
– O₂ plasma at 10⁻¹ mbar, 8 **HI-WAVE** (200 W / source),
– N₂ plasma at 10⁻¹ mbar, 8 **HI-WAVE** (200 W / source).

In this example it is possible to integrate up to 16 **HI-WAVE** for 300 mm processing.

SET-UP of HI-WAVE and solid state microwave generator

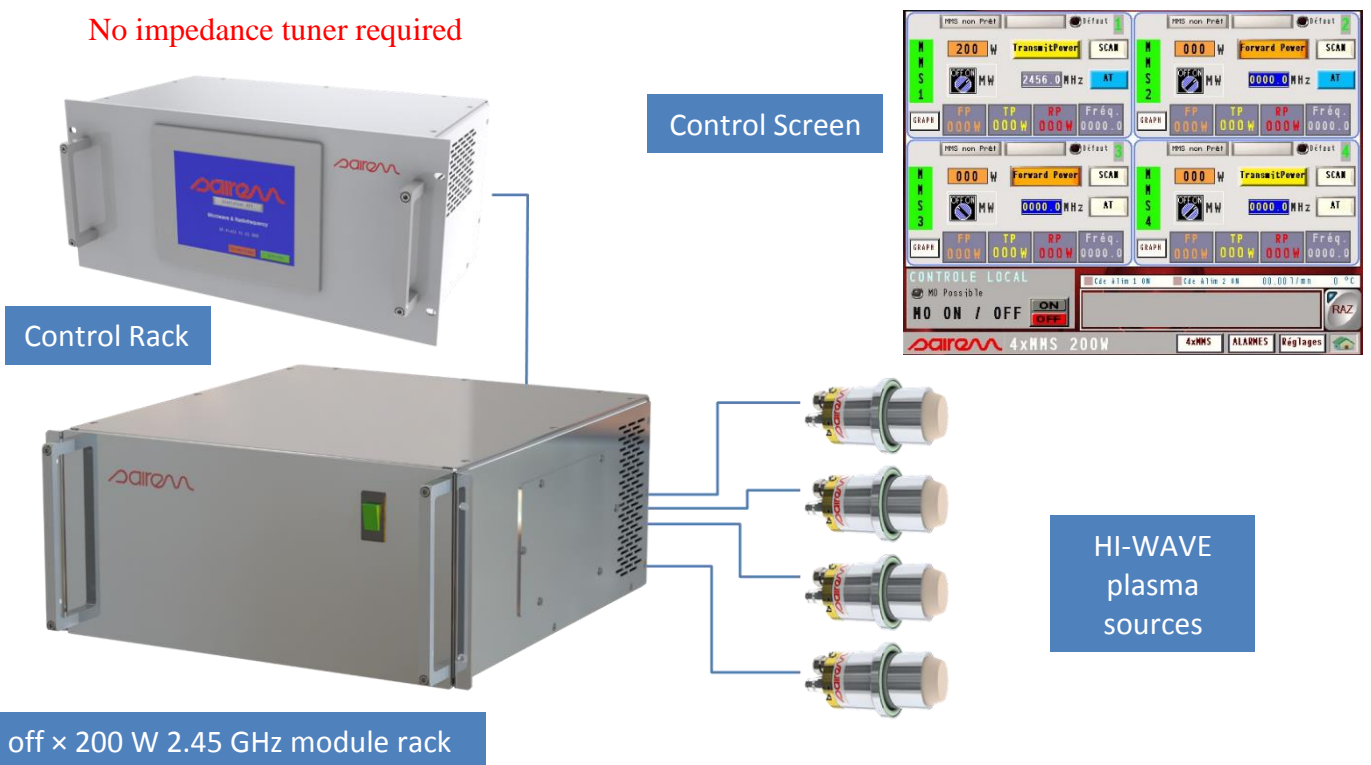
The functionality of the plasma source is possible if the source is connected to a 2.45 GHz solid state microwave generator. In case of multiple plasma sources, solid state modules can be integrated; the control can be done via CANopen® or via a control rack with a touch screen.

Standard HI-WAVE set-up No impedance tuner required



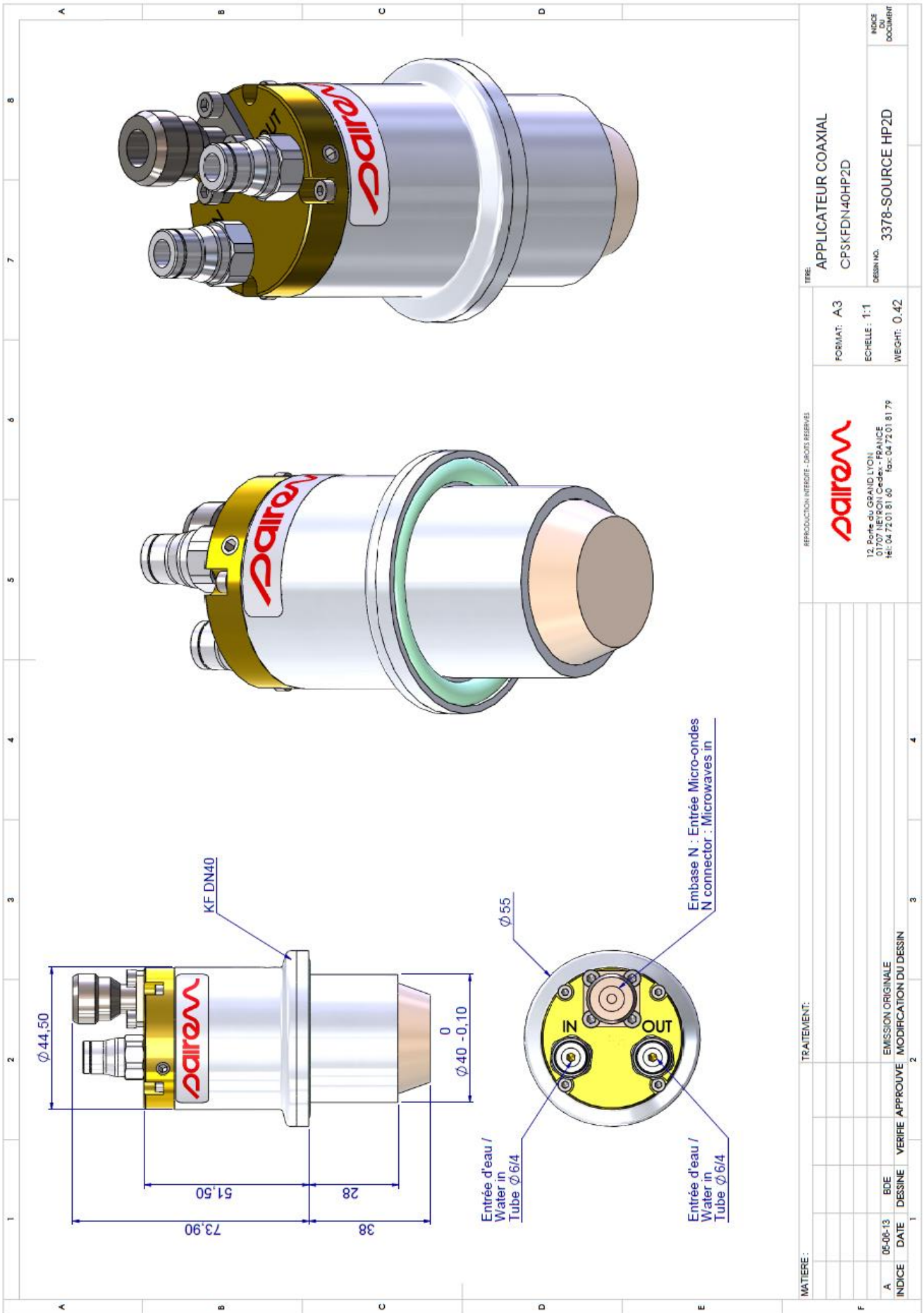
Multiple HI-WAVE set-up. The control rack permits to control each HI-WAVE with 1 W step

No impedance tuner required



REFERENCES

- [1] L. Latrasse, M. Radoiu, J.-M. Jacomino, B. Depagneux, Design of an ECR coaxial microwave plasma source "Aura-Wave" using solid state microwave generator, 14th International Conference on Microwave and High Frequency Heating, Nottingham, UK (2013).
- [2] L. Latrasse, M. Radoiu, J.-M. Jacomino, A. Grandemenge, Facility for microwave treatment of a load, Patent WO 2012146870.
- [3] L. Latrasse, M. Radoiu, Dispositif élémentaire d'application d'une énergie micro-onde avec applicateur coaxial, Patent BR085601.
- [4] L. Latrasse, M. Radoiu, Dispositif élémentaire de production d'un plasma avec applicateur coaxial, Patent BR085602.



MATERIE:		TRAITEMENT:		REPRODUCTION INTERDITE - DROITS RESERVEE		TITRE:		INDICE DU DOCUMENT	
				sairem		APPLICATEUR COAXIAL		3378-SOURCE HP2D	
				12, Porte du GRAND LYON		FORMAT: A3		CPSKFDN40HP2D	
				01700 NEYRON Cedex - FRANCE		ECHELLE: 1:1			
				Tel: 04.72.01.81.50 Fax: 04.72.01.81.79		DESIGN NO. 3378-SOURCE HP2D			
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